

Search Notes

Application/Control No.

10/654,500

Examiner

Ren L. Yan

Applicant(s)/Patent under
Reexamination

HASHI ET AL.

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
101	489	6/7/05	R. Yan
360	17		
	133		
	137		
428	692		
	694T		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR